

Notice of References Cited

Application/Control No.

10/008,646

Applicant(s)/Patent Under
Reexamination
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Examiner

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Art Unit

1773

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	K	US-			
	L	US-			
	M	US-			

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	V	Fuke, H., Saito, K., Yoshikawa, M., Iwasaki, H., and Sahashi, M., App. Phys. Let., 75(23), 1999, 3680 - 3682.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.